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Effects of Wavelength Variation on Localized Photoemission in Triangular Gold Antennas

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PSU Student Research Symposium 2019

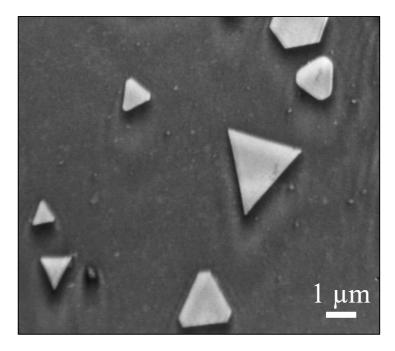
Effects of Wavelength Variation on Localized Photoemission in Triangular Gold Antennas

Christopher M. Scheffler, Robert. C Word, Rolf Könenkamp

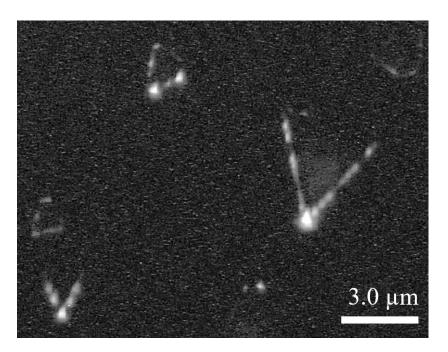
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Motivation

• Prior work at PSU observed interesting optical responses from triangular gold structures using a photoemission electron microscopy (PEEM).



PEEM micrograph of an array of gold microstructures excited with 244 nm continuous-wave light incident at $\theta = 60^{\circ}$. Micrograph provided by Dr. Robert C. Word. (Reference 1)



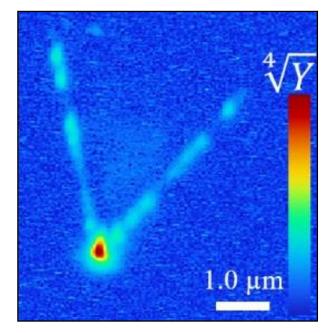
PEEM Micrograph of the same region excited with 800 nm pulsed light incident at $\theta = 60^{\circ}$. Micrograph provided by Dr. Robert Word. (Reference 2)

Project Overview

- Recreate optical effects seen in PEEM in computer modeling.
- Explain the underlying and overall optical responses (theory and simulation).
- Evaluate dependencies of the optical responses on the:
 - a) Polarization of the incident laser

(i.e. orientation of the electric field of the light)

b) Wavelength of the incident laser (i.e. energy of the light)



PEEM Micrograph of a gold triangle excited with 800 nm pulsed light incident at $\theta = 60^{\circ}$. Digitally magnified and colorized. (Reference 2)

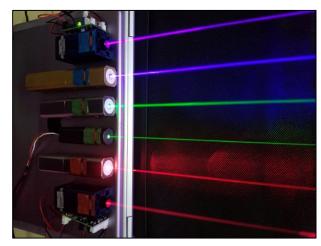
Introduction

- Advancements in fabrication methods enable the straightforward creation of micron- and nanometer-sized devices and structures.
- Modern laser technology enables the creation of optical devices.
- Optical devices have been utilized in a wide range of applications,

including: light localization, microscopy, phototherapy, and sensors.



Zeiss Orion NanoFab (Reference 3)



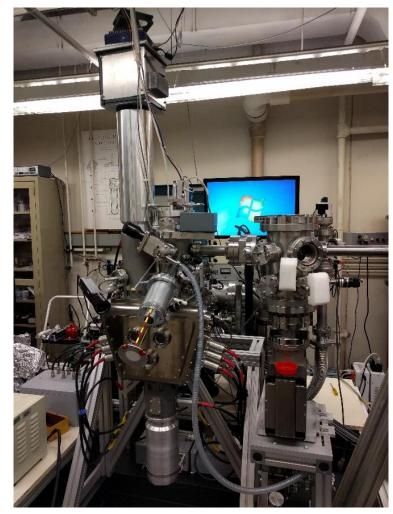
Various lasers (Reference 4)

Photoemission Electron Microscope (PEEM)

- A sample is placed within a high-vacuum environment.
- A high-powered laser is incident onto the sample, which will cause electrons to be ejected from the material

(through the photoelectric effect)

- These photoemitted electrons are collected and used to form and acquire a digital image.
- PSU: Best demonstrated resolution of 5 nm.



Könenkamp Nanophotonics Lab PEEM. (Reference 1)

Sample Details

• Thin, triangular gold platelets are deposited

on a simple planar stack of an insulator (ITO) on top of glass.

- Gold platelets:
 - Single-crystalline
 - 50 100 nm in thickness
 - Most are $\sim 2 5$ um in length

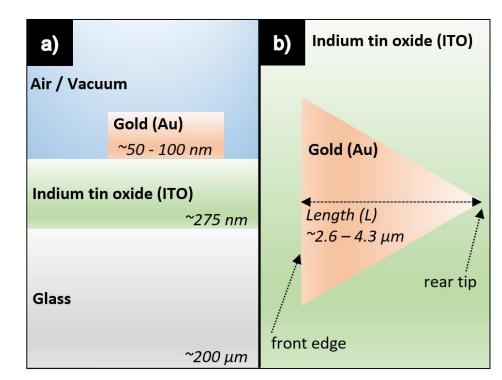


Image not to scale.

- (a) Cross-sectional view
- (b) Top-down view

(Refence 2)

• For this work:

Oblique incidence: 60° (directly from above)

or

7

Normal incidence: 0° (via transmission from below)

 $\lambda = 800 \text{ nm}$ (wavelength of incident laser)

(Simulation: $\lambda = \sim 600 \text{ nm} : 1 \mu \text{m}$)

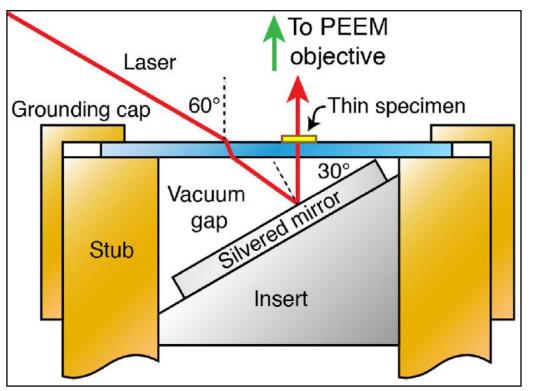


Illustration of the PEEM specimen stub, depicting oblique (from above) and normal (below) incidence. (Reference 5)

• Image reprinted with permission from *Photonic and plasmonic surface field distributions characterized with normal- and oblique-incidence multiphoton PEEM*, by R.C. Word and R. Könenkamp, Ultramicroscopy, vol. 183, pp. 1139-1351, 2017.

Experimental Results

• PEEM micrographs were obtained for transverse

magnetic (TM) polarizations at an oblique angle from above the sample.

• Localized photoemission is seen primarily at the rear tip

region and along the edges.

• PEEM micrographs were obtained at a normal

incidence from below the sample.

• Localized photoemission is seen along the edges.

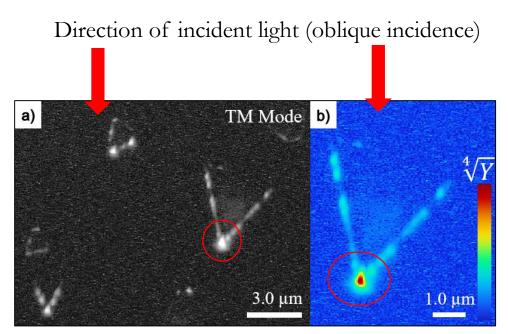
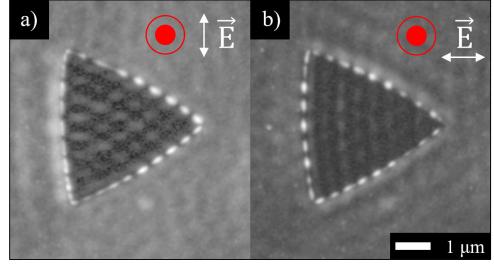


Image (b) is digitally magnified and colored from (a). (Reference 2)



Normal incidence PEEM micrographs. (Reference 5)

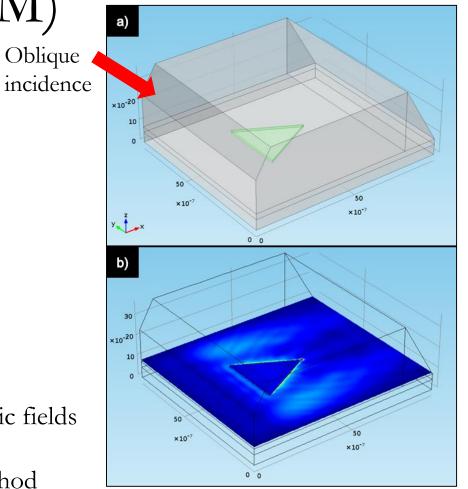
• Adapted with permission from *Photonic and plasmonic surface field distributions characterized with normal- and oblique-incidence multi-photon PEEM*, by R.C. Word and R. Könenkamp, Ultramicroscopy, vol. 183, pp. 1139-1351, 2017.

Finite Element Modeling (FEM)

- COMSOL Multiphysics is used to model the PEEM setup:
 - Recreate PEEM experiment in a 2D- or 3D-model.
 - Assign optical material properties to each layer
 - Specify a light source (i.e. laser)
 - Define boundary conditions
 - COMSOL will calculate the (time-averaged) electromagnetic fields

for each point within the model using a finite-element method

(FEM) analysis technique.



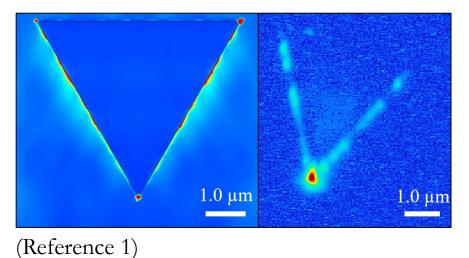
COMSOL Multiphysics 3D Model:

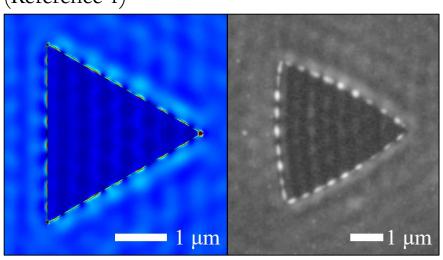
- (a) Au region highlighted in green
- (b) Simulated $|\mathbf{E}|^2$ at the surface of the Au layer.

(Reference 2)

Results: Simulation vs. Experiment

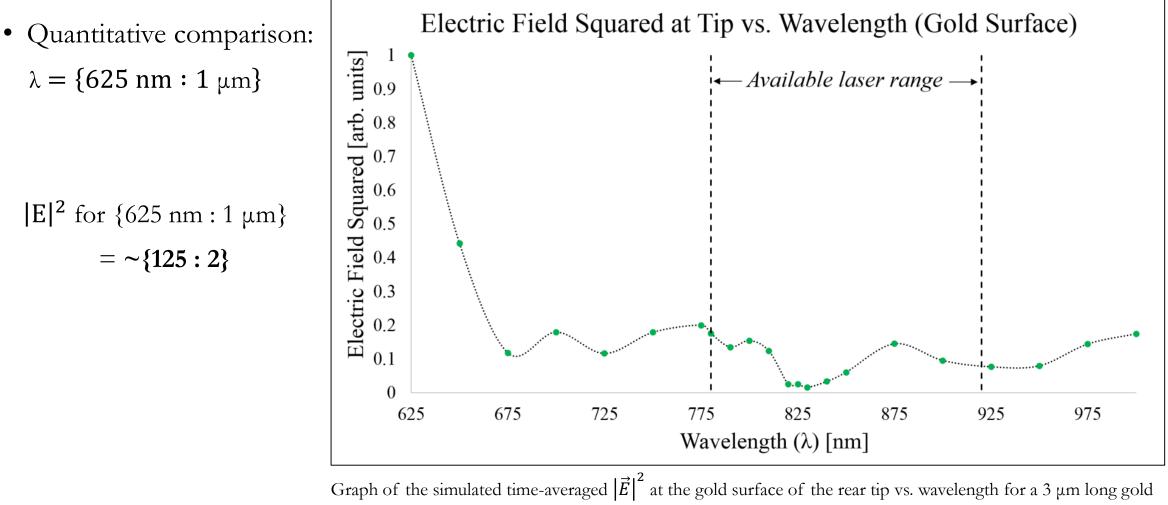
- For oblique incidence, the simulations have approximately reproduced the optical responses seen in PEEM:
 - Strong rear tip photoemission
 - Less intense emission along the exterior edges
 - No visible surface interference patterning
- For normal incidence, simulations have closely reproduced the PEEM optical responses:
 - Strong, periodic photoemission along the exterior edges
 - Distinctive interference patterning within the Au layer





(Reference 1)

Analysis: Wavelength Dependence (λ)



platelet exposed to obliquely incident light ($\theta = 60^{\circ}$) for $\lambda = \{625 \text{ nm} : 1 \mu m\}$. (Reference 1)

Conclusion

• PEEM imaging of gold nano-platelets is a powerful tool for characterizing optical

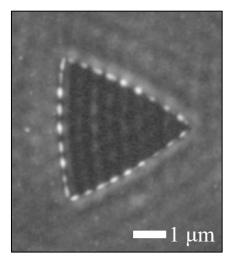
responses with sub-wavelength resolution.

- Combined with FEM based modeling, detailed quantitative analysis can be performed.
- In this work, we have demonstrated:
 - Strong, localized photoemission within a region far smaller than the wavelength

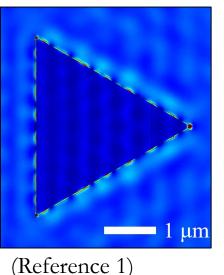
of the incident light (< 250 nm vs. 800 nm).

• Wavelength adjustment at readily available optical frequencies is highly effective

and feasible for controlling photoemission of triangular gold optical antennas.







Acknowledgements

• Theodore Stenmark (PSU)



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Thank you for attending.

